

Analogue Electronics

2nd lecture:

- Miller transformation
- single transistor circuit elements:
 - common emitter
 - common base
 - emitter follower

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Lecture 2

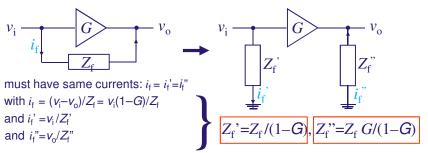


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Miller transformation: definition

- problem: amplifier circuits with feedback elements are quite difficult to solve
- solution: convert feedback circuit into separate input and output circuits that are easier to solve & give better understanding of high-frequency behaviour
- example: amplifier with gain $G=v_o/v_i$ and feedback impedance $Z_i=(v_i-v_o)/i_i$:



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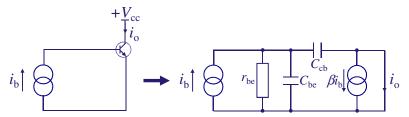
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Miller transformation: example

· problem: small signal frequency response of BJT



- use hybrid π model (sometimes also called Giacolleto model)
- driven by an ideal current source, hence $r_{\rm bb}=0$ has no effect
- load impedance on collector is zero, hence $r_{\rm cb}$ and $r_{\rm ce}$ can be omitted
- without load, any voltage change at input will cause no change in output voltage, hence $\emph{G}=0$ without load

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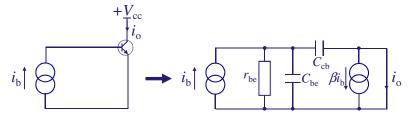


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Miller transformation: example

· problem: small signal frequency response of BJT

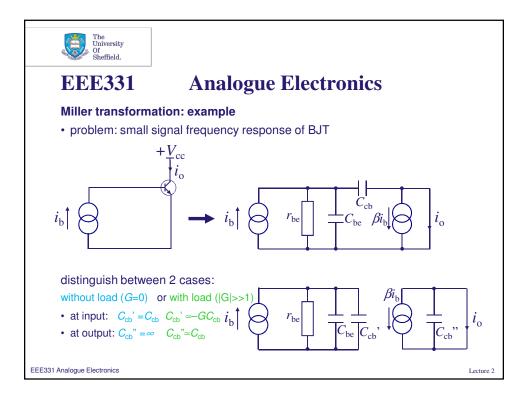


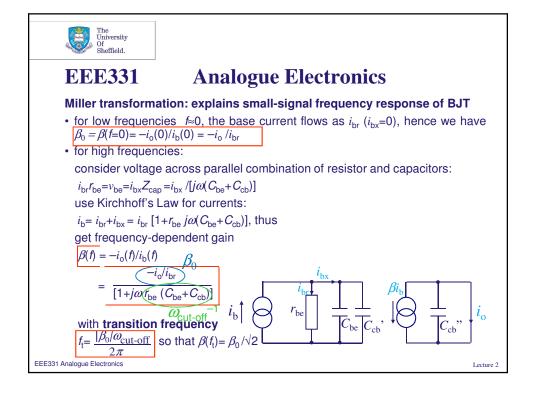
- identify feedback elements between input and output: C_{cb}
- remember: we derived **Miller transformation for impedance Z**, hence for a capacitor this means we have to use $1/(j\omega C)$, which e.g. on the input side becomes $1/[j\omega C(1-G)]$.
- so, for input side:

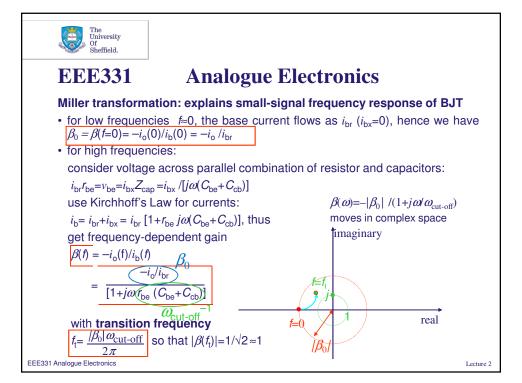
 $C_{cb}' = C_{cb}(1-G)$ $C_{cb}'' = C_{cb}(G-1)/G$

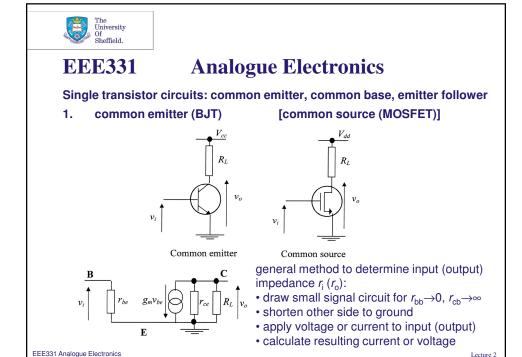
· and for output side:

. .





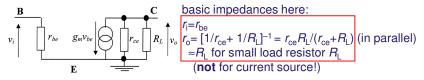






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1. common emitter (BJT)



calculation of voltage gain:

consider output voltage:

voltage gain:

$$\begin{array}{l} v_{\rm o} = -g_{\rm m} v_{\rm be} \; r_{\rm ce} R_{\rm L}/(r_{\rm ce} + R_{\rm L}), \; {\rm thus} \\ \hline v_{\rm o}/v_{\rm i} = v_{\rm o}/v_{\rm be} = -g_{\rm m} \; r_{\rm ce} R_{\rm L}/(r_{\rm ce} + R_{\rm L}) \approx -g_{\rm m} R_{\rm L} \\ {\rm for \; small \; loads \;} R_{\rm L}, \; {\rm i.e. \; the \; voltage \; gain \; is} \end{array}$$

for small loads R_L , i.e. the voltage gain is high and controlled by the load R_L . This is relevant for voltage gain stages in OpAmps.

common source (MOSFET)

 $r_i \rightarrow \infty$ (gate capacitance is open circuit at dc) High input resistance makes MOSFET particularly attractive as input stages of OpAmps!

 $r_o = r_{ds}R_L/(r_{ds} + R_L) \approx R_L$ (as above)

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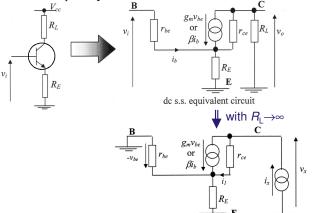
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1. common emitter (BJT)

emitter degeneration: additional impedance between emitter and ground **calculation of low frequency behaviour:**



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1. common emitter (BJT)

emitter degeneration: additional impedance between emitter and ground calculation of low frequency impedance:

consider current:
$$i_1 = i_x - g_m v_{be}$$
 with voltage $-v_{be} = i_x r_{be} R_E / (r_{be} + R_E)$
 $= i_x + g_m i_x r_{be} R_E / (r_{be} + R_E)$
output voltage: $v_x = -v_{be} + i_1 r_{ce}$
 $= i_x r_{be} R_E / (r_{be} + R_E) + [i_x + g_m i_x r_{be} R_E / (r_{be} + R_E)] r_{ce}$
 $= i_x \{ r_{be} R_E / (r_{be} + R_E) + r_{ce} [1 + g_m r_{be} R_E / (r_{be} + R_E)] \}$

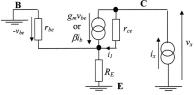
impedance: $V_x/i_x = r_{be}R_E/(r_{be}+R_E) + r_{ce} [1+g_m r_{be}R_E/(r_{be}+R_E)]$ $\approx r_{\rm ce} \left[1 + g_{\rm m} r_{\rm be} R_{\rm E} / (r_{\rm be} + R_{\rm E})\right]$ (for large $g_{\rm m}$)

output impedance has increased drastically!

note:

voltage across $R_{\rm F}$ limits $v_{\rm be}$, hence also i_b and i_c : emitter degenerated circuits are important for design of high impedance loads!

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1. common emitter (BJT)

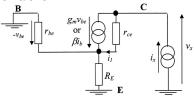
emitter degeneration: additional impedance between emitter and ground calculation of low frequency transconductance:

input voltage:
$$v_{\rm i} = i_{\rm b} r_{\rm be} + (i_{\rm b} + \beta i_{\rm b}) R_{\rm E}$$
 with $r_{\rm be} = v_{\rm be}/i_{\rm b} = g_{\rm m} v_{\rm be}/g_{\rm m} i_{\rm b} = \beta/g_{\rm m}$
= $i_{\rm c} \left[1/g_{\rm m} + R_{\rm E} (1 + 1/\beta) \right]$

transconductance:

$$\frac{i_{\rm c}/v_{\rm i} = 1/\left[1/g_{\rm m} + R_{\rm E}/(1+1/\beta)\right]}{\approx g_{\rm m}/(1+g_{\rm m}R_{\rm E})\right]} \approx g_{\rm m}/(1+g_{\rm m}R_{\rm E})$$
 (since $\beta >> 1$)

transconductance $dI_c/dV_{be} | V_{ce=const.}$ is reduced by a **factor** $(1+g_m R_E)$, i.e. for the CE circuit with R_E it is lower than for the BJT alone





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note for common source (MOSFET):

source degeneration is less common than emitter generation because

- g_m is low anyway, and further reduction is undesirable
- rising input impedance would be pointless as $R_i \rightarrow \infty$ anyway
- rising output impedance generally is beneficial for creating high impedance load but adverse if we are trying to build an output stage (which would require a low output impedance).

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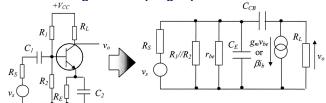


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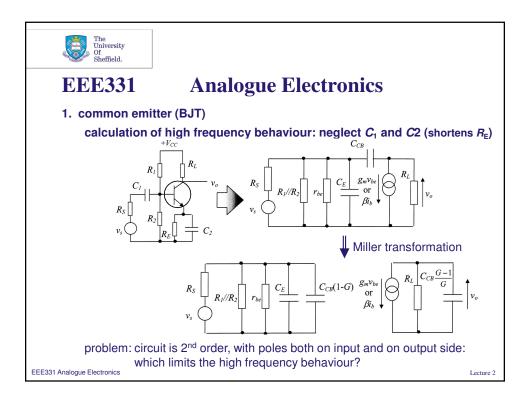
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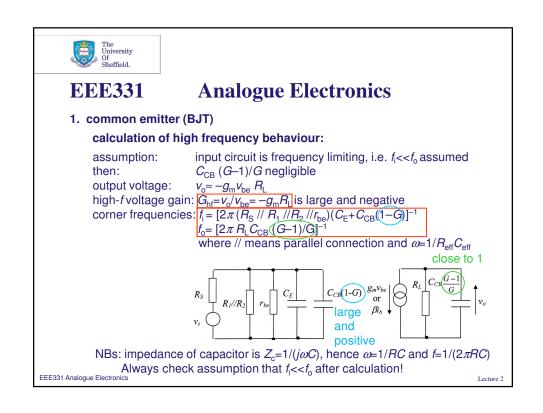
1. common emitter (BJT)

general bias settings and coupling capacitances:



- resistors R_1 , R_2 and R_E define bias conditions of the BJT
- R_1 and R_2 are connected to a constant voltage and so, from a small signal point of view, appear to be in parallel
- $r_{\rm bb} << R_{\rm S}$ (in series) and $r_{\rm ce} >> R_{\rm L}$ (in parallel) can both be ignored
- capacitor C_1 is a bypass capacitor that transmits the time-varying v_s to the base of the BJT without disturbing the dc bias conditions
- capacitor C_2 is another bypass capacitor; it effectively compensates the negative feedback provided by $R_{\rm E}$, thereby increasing gain
- at high frequencies, C_{CB} and C_E cannot be ignored.
- with voltage gain $G=v_0/v_{\rm be}$, $C_{\rm CB}$ becomes the target for the Miller transformation Lecture







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1. common emitter (BJT)

calculation of mid frequency behaviour:

assumption: C_1 and C_2 are still short circuits, but C_{CB} and C_E open

 C_{CB} (G-1)/G negligible then:

output voltage: $v_o \approx -g_m v_{be} R_L$ mid-f voltage gain: $G_{mf} = v_o/v_i = -g_m R_L (R_1 //R_2 //r_{be})/(R_S + R_1 //R_2 //r_{be})$

NBs: Miller effect describes the apparent increase of C_{CB} by factor (1–G), which reduces the corner frequency. Dominant pole compensation means that in practice extra capacitance is often added between base and collector of BJTs of multi-transistor amplifier stages such as OpAmps to separate the pole frequencies due to the different stages, thereby avoiding instabilities and ensuring stable operation.

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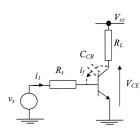


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1. common emitter (BJT) / [common source (MOSFET)] slew rate limiting:

For ${\bf large}$ input signals, the rate of change of ${\it V}_{\rm CE}$ is dominated by the availability of the base drive current. Consider I=dQ/dt=d(CV)/dt=C dV/dt[in analogy, for a power MOSFET the rate of change of drain voltage is governed by the availability of gate drive current].



consider BJT drive on process:

 v_s = 0 for t<0, V_1 for $t \ge 0$ current to base for $t \ge 0$: $I_1 = (V_1 - V_{BE})/R_S$ current to collector for $t \ge 0$: $I_f = C_{CB} dV_{CE}/dt$ Rate of change at output is maximum when all the base current available is utilised by capacitor, i.e. $I_f + I_B = 0$, thus

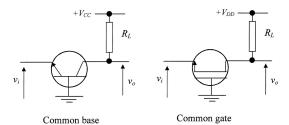
 $\frac{\mathrm{d}\,V_{\mathrm{CE}}/\mathrm{d}\,t\,|_{\mathrm{max-on}} = I_{\mathrm{f}}/C_{\mathrm{CB}} = -I_{\mathrm{B}}/C_{\mathrm{CB}}}{= -\left(\,V_{\mathrm{1}} - V_{\mathrm{BE}}\right)/(R_{\mathrm{S}}C_{\mathrm{CB}})}\,\mathrm{lags\ behind}$

and correspondingly $dV_{CE}/dt|_{\text{max-off}} = V_{BE}/(R_{S}C_{CB})$ leads



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2. common base (BJT) / [common gate (MOSFET)]



voltage gain: $G = g_{\rm m}R_{\rm l}$

 $i_{\rm o}/i_{\rm i}=1/(1+1/G)$ (i.e. <1: **no current gain**, as $I_{\rm C} \le I_{\rm E}$) 1. $C_{\rm CB}$ does not cause high frequency feedback: current gain: advantages:

ideal for **fast switches** (no Miller effect as $I_{\mathbb{C}} \approx I_{\mathbb{E}}$) 2. for large R_L , output impedance is higher than in CE mode, i.e. use as current source

derivation: cf section 3.3.3 in Gray's textbook

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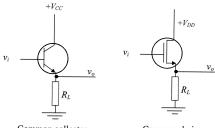
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3. common collector = emitter follower (BJT) / [common drain (MOSFET)]



Common collector

Common drain

use Kirchoff's law at output node: $(v_i-v_o)/r_{be}+\beta (v_i-v_o)/r_{be}-v_o/R_L=0$, thus voltage gain: $G=v_o/v_i=R_L(1+\beta)/[r_{be}+R_L(1+\beta)]=1/[1+r_{be}/(\beta+1)R_L]\approx g_mR_L/(1+g_mR_L)\cong 1$ Note: The gain is usually just less than unity, so the emitter follows the input voltage (hence the name emitter follower). These circuits have high input impedance and low output impedance and are useful for buffers.